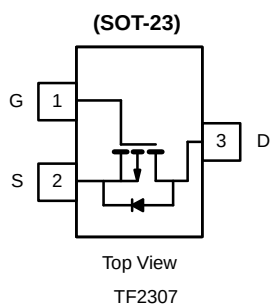


P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
-30	0.055 @ $V_{GS} = -10$ V	-4.1
	0.075 @ $V_{GS} = -4.5$ V	-3.0



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	-30	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 150^\circ\text{C}$) ^{a, b}	$T_A = 25^\circ\text{C}$	I_D	-4.1	A
Pulsed Drain Current		I_{DM}	-12	
Continuous Source Current (Diode Conduction) ^{a, b}		I_S	-1.25	
Power Dissipation ^{a, b}	$T_A = 25^\circ\text{C}$	P_D	1.25	W
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^a	$t \leq 5$ sec	R_{thJA}		100	$^\circ\text{C/W}$
	Steady State		130		

Notes

a. Surface mounted on FR4 board.

b. $t \leq 5$ sec.

**SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)**

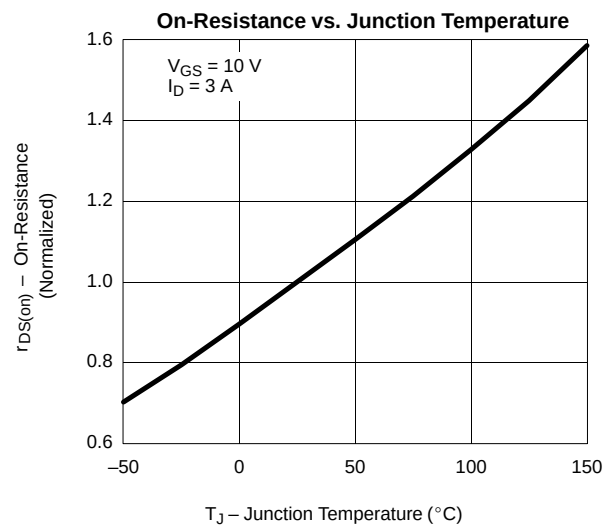
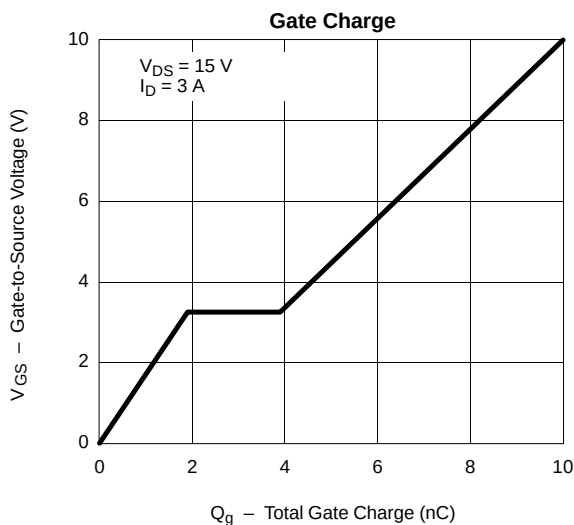
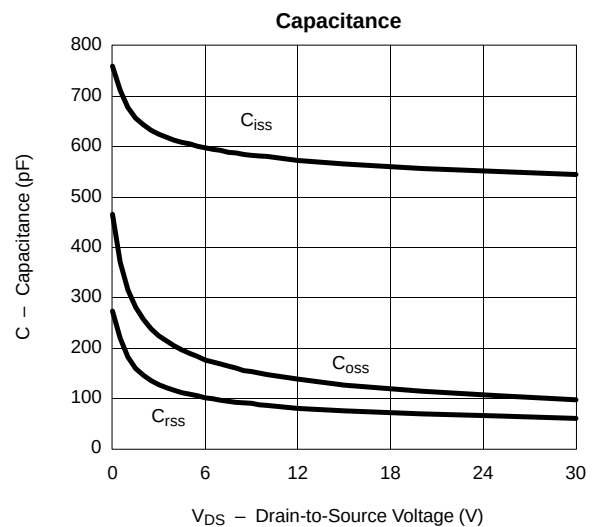
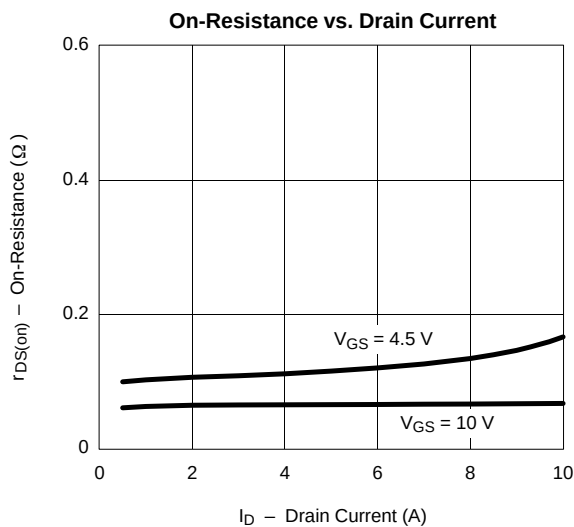
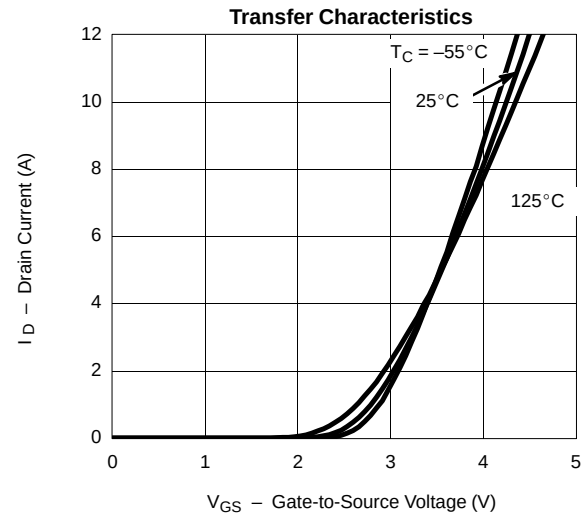
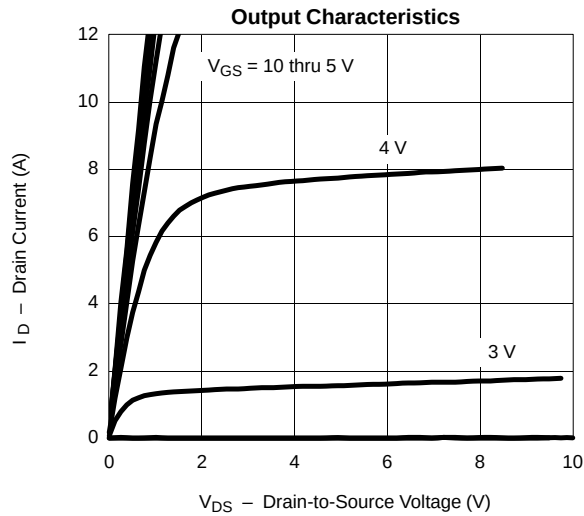
Parameter	Symbol	Test Conditions	Limits			Unit
			Min	Typ	Max	
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = -10\text{ }\mu\text{A}$	-30			V
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$	-0.8		3.0	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$			-1	μA
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \leq -5\text{ V}, V_{GS} = -10\text{ V}$	-6			A
Drain-Source On-Resistance ^a	$r_{DS(on)}$	$V_{GS} = -10\text{ V}, I_D = -4.1\text{ A}$		0.050	0.055	Ω
		$V_{GS} = -4.5\text{ V}, I_D = -3.0\text{ A}$		0.065	0.075	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -10\text{V}, I_D = -3\text{ A}$		4.5		S
Diode Forward Voltage	V_{SD}	$I_S = -1.25\text{ A}, V_{GS} = 0\text{ V}$			-1.0	V
Dynamic ^b						
Total Gate Charge	Q_g	$V_{DS} = -15\text{ V}, V_{GS} = -10\text{ V}$ $I_D \cong -3\text{ A}$		10	15	nC
Gate-Source Charge	Q_{gs}			1.9		
Gate-Drain Charge	Q_{gd}			2		
Input Capacitance	C_{iss}	$V_{DS} = -15\text{ V}, V_{GS} = 0, f = 1\text{ MHz}$		565		pF
Output Capacitance	C_{oss}			126		
Reverse Transfer Capacitance	C_{rss}			75		
Switching ^b						
Turn-On Time	$t_{d(on)}$	$V_{DD} = -15\text{ V}, R_L = 15\text{ }\Omega$ $I_D \cong -1.0\text{ A}, V_{GEN} = -10\text{ V}$ $R_G = 6\text{ }\Omega$		10	20	ns
	t_r			9	20	
Turn-Off Time	$t_{d(off)}$			27	50	
	t_f			7	16	

Notes

- a. Pulse test: $PW \leq 300\text{ }\mu\text{s}$ duty cycle $\leq 2\%$.
b. For DESIGN AID ONLY, not subject to production testing.
c. Switching time is essentially independent of operating temperature.



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)





TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

